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PATENT STATUS

OTHER INFORMATION

KEYWORDS

Transition Metal Dichalcogenides,
Monolayer MoS₂, Molybdenum
Disulfide, 2 dimensional nanosheets,
Photoluminescence, Photodetectors,
Semiconductors, Optoelectronics,
Chemical sensors, Solar cells,
Electrodes, Valleytronics, Logic
circuits, High efficiency on/off
switches

CATEGORIZED AS

- ▶ **Optics and Photonics**
 - ▶ All Optics and Photonics
- ▶ **Communications**
 - ▶ Optical
- ▶ **Computer**
 - ▶ Hardware
- ▶ **Energy**
 - ▶ Solar
 - ▶ Storage/Battery
- ▶ **Materials & Chemicals**
 - ▶ Chemicals
 - ▶ Electronics Packaging
 - ▶ Superconductors
- ▶ **Semiconductors**
 - ▶ Design and Fabrication
 - ▶ Processing and Production
- ▶ **Sensors & Instrumentation**
 - ▶ Environmental Sensors




Figure 1a shows the plot of Drain current (A) versus Gate voltage (V). The y-axis is logarithmic, ranging from 10^{-10} to 10^{-6} A. The x-axis ranges from -100 V to 100 V. The curve shows a minimum current near 0 V, indicating ambipolar transport.

RELATED CASES

2014-807-0

Plot of drain current versus gate voltage for fabricated FET showing electron transport. The on/off ratio for this device is 300.

ADVANTAGES

The benefits of their technology are:

- ▶ Excellent control of the film thickness by varying the concentration of the solution and spin coating speed.
- ▶ Does not need the use of sulfur or high temperatures for preparation.
- ▶ Can be used to achieve homogeneous alloys and doping of TMDs.
- ▶ Samples can be prepared down to monolayer thickness.

SUGGESTED USES

- ▶ Field effect transistors, high-efficiency switching and logic circuits
- ▶ Photodetectorrss
- ▶ Solar cells
- ▶ Chemical sensors
- ▶ Supercapacitor electrodes
- ▶ Next generation Valleytronics – e.g., quantum computing and qubits.

TESTING

To evaluate, they fabricated Field Effect Transistors (FET) on SiO₂/Si substrate with Ti/Au contacts. FETs show electric mobilities of 0.1 sq. cm per Volt per second.

RELATED MATERIALS

- ▶ [Wafer Scale Synthesis and High Resolution Structural Characterization of Atomically Thin MoS 2 Layers](#)

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